

<b>Notice of References Cited</b>	Application/Control No. 09/845,284	Applicant(s)/Patent Under Reexamination MOCHIZUKI ET AL.	
	Examiner A. Sefer	Art Unit 2826	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,586,769	07-2003	Watanabe et al.	257/72
	B	US-2003/0117557	06-2003	Fujita et al.	349/139
	C	US-2003/0079583	05-2003	FUNAKOSHI et al.	83/13
	D	US-6,573,957	06-2003	Suzuki, Shunji	349/73
	E	US-5,619,223	04-1997	Lee et al.	345/93
	F	US-5,608,558	03-1997	Katsumi, Irie	349/192
	G	US-6,509,949	01-2003	Lu et al.	349/187
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 8-62625	03-1996	Japan	Miyata et al	
	O	JP 8-320502	12-1996	Japan	Koshimizu et al	
	P	JP 9-289181	11-1997	Japan	Tonagoshi et al	
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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